

Data sheet acquired from Harris Semiconductor SCHS018C – Revised September 2003

CMOS Dual Complementary Pair Plus Inverter

High-Voltage Types (20-Volt Rating)

■ CD4007UB types are comprised of three n-channel and three p-channel enhancement-type MOS transistors. The transistor elements are accessible through the package terminals to provide a convenient means for constructing the various typical circuits as shown in Fig. 2.

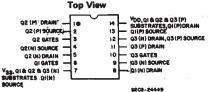
More complex functions are possible using multiple packages. Numbers shown in parentheses indicate terminals that are connected together to form the various configurations listed.

The CD4007UB types are supplied in 14-lead hermetic dual-in-line ceramic packages (F3A suffix), 14-lead dual-in-line plastic packages (E suffix), 14-lead small-outline packages (M, MT, M96, and NSR suffixes), and 14-lead thin shrink small-outline packages (PW and PWR suffixes).

Applications:

- Extremely high-input impedance amplifiers
- Shapers
- Inverters
- Threshold detector
- Linear amplifiers
- **■** Crystal oscillators

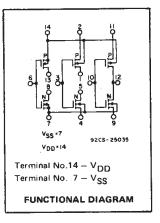
TERMINAL DIAGRAM



CD4007UB Types

Features:

- Standardized symmetrical output characteristics
- Medium Speed Operation tpHL, tpLH = 30 ns (typ.) at 10 V
- 100% tested for quiescent current at 20 V
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"
- Maximum input current of 1 μA at 18 V over full package-temperature range;
 100 nA at 18 V and 25°C



RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

| CHARACTERISTIC | Lif | UNITS | |
|--|------|-------|---|
| | MIN. | MAX. | |
| Supply-Voltage Range | | | |
| (For T _A = Full Package Temperature Range) | 3 | 18 | v |

STATIC ELECTRICAL CHARACTERISTICS

| CHARACTER- | CONE | OITION | IS | LIMITS AT INDICATED TEMPERATURES (°C) | | | | | | | |
|------------------------------------|------|--------|-----|---------------------------------------|------------|-------|-------|-------|-------------------|----------|-------|
| ISTIC | Vo | VIN | VDD | | | | | | +25 | | UNITS |
| | (v) | (V) | (V) | -55 | -40 | +85 | +125 | Min. | Тур. | Max. | |
| Quiescent Dévice | _ | 0,5 | 5 | 0.25 | 0.25 | 7.5 | 7.5 | _ | 0.01 | 0.25 | μΑ |
| Current, | | 0,10 | 10 | 0.5 | 0.5 | 15 | 15 | | 0.01 | 0,5 | |
| IDD Max. | | 0,15 | 15 | 1 | 1 | 30 | 30 | | 0.01 | 1 | |
| | - | 0,20 | 20 | 5 | 5 | 150 | 150 | | 0.02 | 5 | |
| Output Low | 0.4 | 0,5 | 5 | 0.64 | 0.61 | 0.42 | 0.36 | 0.51 | 1 | | |
| (Sink) Current | 0.5 | 0,10 | 10 | 1.6 | 1.5 | 1.1 | 0.9 | 1.3 | 2.6 | - | |
| IOL Min. | 1.5 | 0,15 | 15 | 4.2 | 4 | 2.8 | 2.4 | 34 | 6.8 | | |
| Output High | 4.6 | 0,5 | 5 | -0.64 | -0.61 | -0.42 | -0.36 | -0.51 | -1 | - | mA |
| (Source) | 2.5 | 0,5 | 5 | -2 | 1.8 | -1.3 | -1.15 | -1.6 | -3.2 | | |
| Current, | 9.5 | 0,10 | 10 | -1.6 | -1.5 | -1.1 | -0.9 | -1.3 | -2.6 | _ | |
| IOH Min. | 13.5 | 0,15 | 15 | -4.2 | -4 | -2.8 | 2.4 | -3.4 | -6.8 | _ | |
| Output Voltage: | _ | 0,5 | 5 | | 0 | .05 | | - | 0 | 0.05 | |
| Low-Level, | _ | .0;10 | 10 | | 0 | .05 | | _ | 0 | 0.05 | ٧ |
| VOL Max. | _ | 0,15 | 15 | | 0 | .05 | | - | 0 | 0.05 | |
| Output Voltage: | _ | 0,5 | 5 | | 4 | .95 | | 4.95 | 5 | - | |
| High-Level, | _ | 0,10 | 10 | | 9 | .95 | | 9.95 | 10 | _ | |
| VOH Min. | _ | 0,15 | 15 | | 14 | 1.95 | | 14.95 | 15 | <u> </u> | |
| Input Low | 4.5 | - | 5 | | | 1 | | _ | _ | 1 | |
| Voltage, | 9 | - | 10 | | | 2 | | _ | | 2 | |
| VIL Max. | 13.5 | - | 15 | | | 2.5 | | - | | 2.5 | v |
| Inpút High Voltage, VIH Min. | 0.5 | I - | 5 | | | 4 | | 4 | _ | _ | * |
| | 1 | - | 10 | | | 8 | | 8 | | | |
| | 1.5 | T - | 15 | | 1 | 2.5 | | 12.5 | | _ | |
| Input Current IIN Max. | | 0,18 | 18 | ±0.1 | ±0.1 | ±1 | ±1 | - | ±10 ⁻⁵ | ±0.1 | μА |

CD4007UB Types

MAXIMUM RATINGS, Absolute-Maximum Values:DC SUPPLY-VOLTAGE RANGE, (V_{DD}) -0.5V to +20VVoltages referenced to V_{SS} Terminal)-0.5V to V_{DD} +0.5VINPUT VOLTAGE RANGE, ALL INPUTS-0.5V to V_{DD} +0.5VDC INPUT CURRENT, ANY ONE INPUT $\pm 10mA$ POWER DISSIPATION PER PACKAGE (PD):500mWFor $T_A = -55^{\circ}C$ to $+100^{\circ}C$ 500mWFOR $T_A = +100^{\circ}C$ to $+125^{\circ}C$ Derate Linearity at $12mW/^{\circ}C$ to 200mWDEVICE DISSIPATION PER OUTPUT TRANSISTOR100mWFOR $T_A = FULL$ PACKAGE-TEMPERATURE RANGE (All Package Types)100mWOPERATING-TEMPERATURE RANGE (T_{atg}) $-55^{\circ}C$ to $+125^{\circ}C$ STORAGE TEMPERATURE RANGE (T_{atg}) $-65^{\circ}C$ to $+150^{\circ}C$ LEAD TEMPERATURE (DURING SOLDERING): $+265^{\circ}C$ At distance $1/16 \pm 1/32$ inch $(1.59 \pm 0.79mm)$ from case for 10s max $+265^{\circ}C$

| a) Triple Inverters | 6 8 3 5 5 |
|--------------------------------------|--------------|
| (14,2,11); (8,13); (1,5); (7,4,9) | 92CS-15350 |

(13,2); (1,11); (12,5,8); (7,4,9)

DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C; Input t_r, t_f = 20 ns, C_L = 50 pF, R_L = 200 K Ω

| | COND | ITIONS | LIA | | | |
|---------------------|---------------|--------------------------|-------|------|-------|----|
| CHARACTER | | V _{DD} Volts | Тур. | Max. | UNITS | |
| Propagation Delay T | | 5 | 55 | 110 | | |
| | tPHL. | | 10 | 30 | 60 | ns |
| | tPLH | | 15 | 25 | 50 | 1 |
| | | 1 | 5 | 100 | 200 | |
| Transition Time | tTHL, tTLH | | 10 | 50 | 100 | ns |
| | | | 15 | 40 | 80 | 1 |
| Input Capacitance | CIN | Any | Input | 10 | 15 | pF |

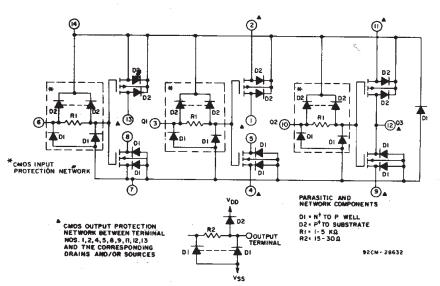


Fig. 1 — Detailed schematic diagram of CD4007UB showing input, output, and parasitic diodes.

c) 3-Input NAND Gate 30 00 12 (1,12,13); (2,14,11); 9205-15348 (4,8); (5,9)

d) Tree (Relay) Logic

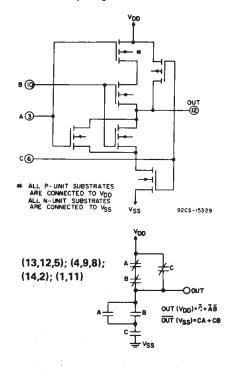
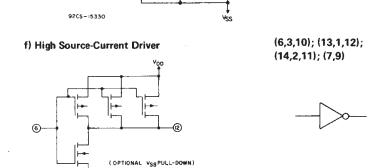


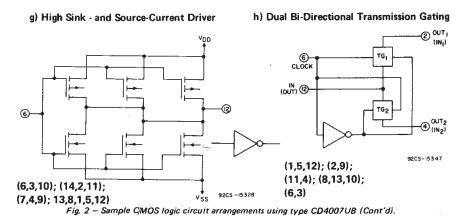
Fig. 2 — Sample C'MOS logic circuit arrangements using type CD4007UB.

CD4007UB Types

e) High Sink-Current Driver (6,3,10); (8.5, 12); (11,14); 7,4,9)



92CS-15327



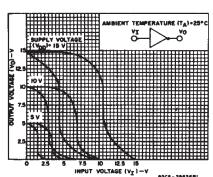


Fig. 6 – Minimum and maximum voltage-transfer characteristics for inverter.

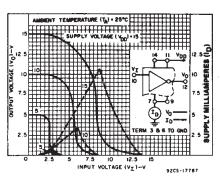


Fig. 7 – Typical current and voltage-transfer characteristics for inverter.

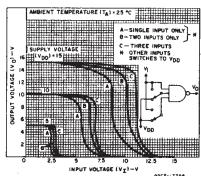


Fig. 3 – Typical voltage-transfer characteristics for NAND gate.

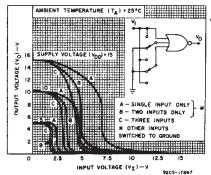


Fig. 4 — Typical voltage-transfer characteristics for NOR gate.

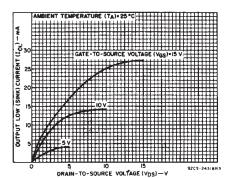


Fig. 5 — Typical output low (sink) current characteristics.

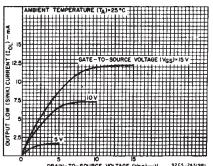


Fig. 8 – Minimum output low (sink)

current characteristics.

CD4007UB Types

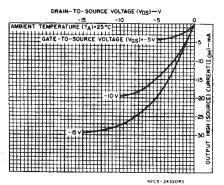


Fig. 9 ~ Typical output high (source) current characteristics.

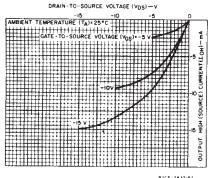


Fig. 10 – Minimum output high (source) current characteristics.

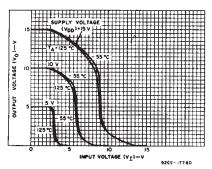


Fig. 11 — Typical voltage-transfer characteristics as a function of temperature.

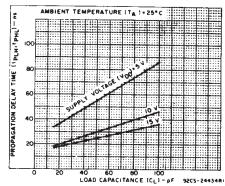


Fig. 12 — Typical propagation delay time vs. load capacitance.

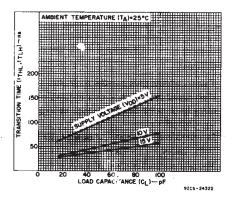


Fig. 13 — Typical transition time vs. load capacitance.

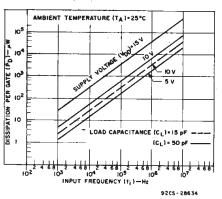


Fig. 14 — Typical dissipation vs. frequency characteristics.

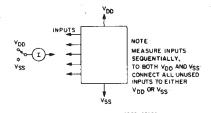


Fig. 15 - Input current test circuit.

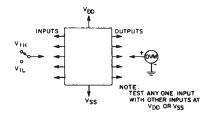


Fig. 16 - Input voltage test circuit.

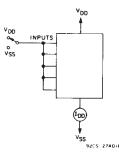
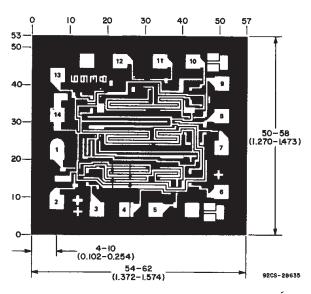


Fig. 17 - Quiescent device current test circuit.



DIMENSIONS AND PAD LAYOUT FOR CD4007UBH

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as Indicated, Grid graduations are in mile (10⁻³ inch).





10-Jun-2014

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|----------------------------|------------------|--------------------|--------------|----------------------|---------|
| CD4007UBE | ACTIVE | PDIP | N | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD4007UBE | Samples |
| CD4007UBEE4 | ACTIVE | PDIP | N | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD4007UBE | Samples |
| CD4007UBF | ACTIVE | CDIP | J | 14 | 1 | TBD | A42 | N / A for Pkg Type | -55 to 125 | CD4007UBF | Samples |
| CD4007UBF3A | ACTIVE | CDIP | J | 14 | 1 | TBD | A42 | N / A for Pkg Type | -55 to 125 | CD4007UBF3A | Samples |
| CD4007UBM | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CD4007UBM | Samples |
| CD4007UBM96 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CD4007UBM | Samples |
| CD4007UBMT | ACTIVE | SOIC | D | 14 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CD4007UBM | Samples |
| CD4007UBNSR | ACTIVE | so | NS | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CD4007UB | Samples |
| CD4007UBNSRG4 | ACTIVE | so | NS | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CD4007UB | Samples |
| CD4007UBPW | ACTIVE | TSSOP | PW | 14 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CM007UB | Samples |
| CD4007UBPWR | ACTIVE | TSSOP | PW | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CM007UB | Samples |
| CD4007UBPWRG4 | ACTIVE | TSSOP | PW | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | CM007UB | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

PACKAGE OPTION ADDENDUM



10-Jun-2014

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD4007UB, CD4007UB-MIL:

Catalog: CD4007UB

Military: CD4007UB-MIL

NOTE: Qualified Version Definitions:

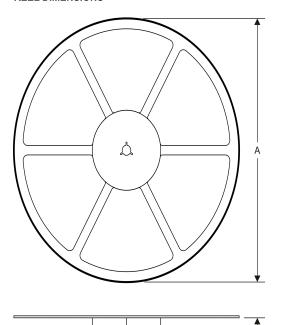
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

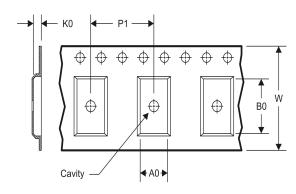
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TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



| A0 | Dimension designed to accommodate the component width |
|----|---|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

TAPE AND REEL INFORMATION

*All dimensions are nominal

| Device | | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|-------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| CD4007UBM96 | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| CD4007UBMT | SOIC | D | 14 | 250 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| CD4007UBNSR | SO | NS | 14 | 2000 | 330.0 | 16.4 | 8.2 | 10.5 | 2.5 | 12.0 | 16.0 | Q1 |
| CD4007UBPWR | TSSOP | PW | 14 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |

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*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CD4007UBM96 | SOIC | D | 14 | 2500 | 367.0 | 367.0 | 38.0 |
| CD4007UBMT | SOIC | D | 14 | 250 | 367.0 | 367.0 | 38.0 |
| CD4007UBNSR | SO | NS | 14 | 2000 | 367.0 | 367.0 | 38.0 |
| CD4007UBPWR | TSSOP | PW | 14 | 2000 | 367.0 | 367.0 | 35.0 |

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
 Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
 Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
 - Sody length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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